

<b>Notice of References Cited</b>	Application/Control No. 10/786,472	Applicant(s)/Patent Under Reexamination ICHIHARA ET AL.	
	Examiner Rodney H. Bonck	Art Unit 3681	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0103848 A1	06-2003	Hayashi, Hirohito	417/212
*	C	US-2004/0026201 A1	02-2004	Imasaka et al.	192/3.28
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	K	US-			
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**NON-PATENT DOCUMENTS**

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